Preferred Device

# **Sensitive Gate** Silicon Controlled Rectifiers

# **Reverse Blocking Thyristors**

Designed for high volume, low cost, industrial and consumer applications such as motor control, process control, temperature, light and speed control.

- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Surface Mount Lead Form Case 369A
- Device Marking: Device Type, e.g., MCR716, Date Code



MAXIMUM RATINGS (TJ = 25°C unless otherwise noted)

(1)  $V_{DRM}$  and  $V_{RRM}$  for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.



## **ON Semiconductor**

http://onsemi.com

# SCRs **4.0 AMPERES RMS** 400 thru 600 VOLTS





D-PAK **CASE 369A** 

STYLE 4
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PIN ASSIGNMENT					
1 Cathode					
2	2 Anode				
3	Gate				
4	Anode				

#### **ORDERING INFORMATION**

Device	Package	Shipping
MCR716T4	DPAK 369A	16mm Tape and Reel (2.5K/Reel)
MCR718T4	DPAK 369A	16mm Tape and Reel (2.5K/Reel)

Preferred devices are recommended choices for future use and best overall value.

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	3.0	°C/W
Thermal Resistance, Junction to Ambient (Case 369A) <sup>(1)</sup>	$R_{\theta JA}$	80	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	ТĻ	260	°C

#### **ELECTRICAL CHARACTERISTICS** ( $T_C = 25^{\circ}C$ unless otherwise noted.)

Characteristic		Symbol	Min	Тур	Max	Unit
DFF CHARACTERISTICS			•			
Peak Repetitive Forward or Reverse Blocking Current; R <sub>G</sub> (V <sub>AK</sub> = Rated V <sub>DRM</sub> or V <sub>RRM</sub> )	$K = 1 K\Omega^{(2)}$ $T_C = 25^{\circ}C$ $T_C = 110^{\circ}C$	IDRM IRRM		_	10 200	μΑ
ON CHARACTERISTICS			•	•		•
Peak Reverse Gate Blocking Voltage (I <sub>GR</sub> = 10 μA)		VRGM	10	12.5	18	Volts
Peak Reverse Gate Blocking Current (V <sub>GR</sub> = 10 V)		IRGM	-	—	1.2	μA
Peak Forward On-State Voltage <sup>(3)</sup> (I <sub>TM</sub> = 5.0 A Peak) (I <sub>TM</sub> = 8.2 A Peak)		VTM		1.3 1.5	1.5 2.2	Volts
Gate Trigger Current (Continuous dc) <sup>(4)</sup> (V <sub>D</sub> = 12 Vdc, R <sub>L</sub> = 30 Ohms)	$T_C = 25^{\circ}C$ $T_C = -40^{\circ}C$	lgt	1.0	25 —	75 300	μΑ
Gate Trigger Voltage (Continuous dc) <sup>(4)</sup> (V <sub>D</sub> = 12 Vdc, R <sub>L</sub> = 30 Ohms)	$T_{C} = 25^{\circ}C$ $T_{C} = -40^{\circ}C$ $T_{C} = 110^{\circ}C$	VGT	0.3 — 0.2	0.55 —	0.8 1.0 —	Volts
Holding Current(2) (V <sub>D</sub> = 12 Vdc, Initiating Current = 200 mA, Gate Open)	$T_{C} = 25^{\circ}C$ $T_{C} = -40^{\circ}C$	ΙΗ	0.4	1.0	5.0 10	mA
Latching Current(2) (V <sub>D</sub> = 12 Vdc, I <sub>G</sub> = 2.0 mA, T <sub>C</sub> = 25°C) (V <sub>D</sub> = 12 Vdc, I <sub>G</sub> = 2.0 mA, T <sub>C</sub> = $-40^{\circ}$ C)		١L			5.0 10	mA
Total Turn-On Time (Source Voltage = 12 V, $R_S = 6 K\Omega$ , $I_T = 8 A(pk)$ , $R_{GK} = (V_D = Rated V_{DRM}$ , Rise Time = 20 ns, Pulse Width = 1		tgt	_	2.0	5.0	μs

#### DYNAMIC CHARACTERISTICS

Critical Rate of Rise of Off–State Voltage ( $V_D = 0.67 \text{ x}$ Rated $V_{DRM}$ , $R_{GK} = 1 \text{ K}\Omega$ , Exponential Waveform, $T_J = 110^{\circ}\text{C}$ )	dv/dt	5.0	10	_	V/µs
Repetitive Critical Rate of Rise of On–State Current (f = 60 Hz, $I_{PK}$ = 30 A, PW = 100 µs, dIG/dt = 1 A/µs)	di/dt		_	100	A/μs

(1) Case 369A, when surface mounted on minimum recommended pad size.

(2) Ratings apply for negative gate voltage or R<sub>GK</sub> = 1 KΩ. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.

(3) Pulse Test: Pulse Width  $\leq$  2 ms, Duty Cycle  $\leq$  2%.

(4)  $R_{GK}$  current not included in measurements.

# Voltage Current Characteristic of SCR

	Ĵ.	+ Current Anode +
Symbol	Parameter	
V <sub>DRM</sub>	Peak Repetitive Off State Forward Voltage	
IDRM	Peak Forward Blocking Current	on state
VRRM	Peak Repetitive Off State Reverse Voltage	I <sub>RRM</sub> at V <sub>RRM</sub>
IRRM	Peak Reverse Blocking Current	
VTM	Peak On State Voltage	+ Voltage
Ι <sub>Η</sub>	Holding Current	Reverse Blocking Region
		(off state) Forward Blocking Region   Reverse Avalanche Region (off state)   Anode –
110		S 5.0 4.0 80°C
105	30°C 90°L 120 180 DC	C _ C _ C _ C _ C _ C _ C _ C _ C _ C _
	1.0 2.0 3.0 4.0	C - C - C - C - C - C - C - C - C - C -
)	I <sub>T(AV)</sub> , AVERAGE ON-STATE CURRENT (AMPS)	I <sub>T(AV)</sub> , AVERAGE ON–STATE CURRENT (AMPS)
	Figure 1. Average Current Derating	Figure 2. On–State Power Dissipation
100 Е Туріса	al @ $T_J = 25^{\circ}C$	
10	Maximum @ T」 = 110'	$^{\circ}$ C – $Z_{\Theta JC(t)} = R_{\Theta JC(t)} \bullet r(t)$
	Maximum @ T <sub>J</sub> = 25°C	
100 Typica 10 1.0		C = 0.1
0.1		0.01
0.5 1	1.0     1.5     2.0     2.5     3.0     3.5     4.0       V <sub>T</sub> , INSTANTANEOUS ON–STATE VOLTAGE (VOLTS)	4.5 0.1 1.0 10 100 1000 10,000 t, TIME (ms)
,		
	Figure 3. On–State Characteristics	Figure 4. Transient Thermal Response



Figure 5. Typical Gate Trigger Current versus Junction Temperature



Figure 6. Typical Gate Trigger Voltage versus Junction Temperature



Figure 7. Typical Holding Current versus Junction Temperature



Figure 8. Typical Latching Current versus Junction Temperature

### MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to insure proper solder connection

interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



### PACKAGE DIMENSIONS

D-PAK CASE 369A-13 **ISSUE Z** 



NOT						
1.	1. DIMENSIONING AND TOLERANCING PER ANSI					
Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.						
INCHES MILLIMETERS						
	DIM	MIN	MAX	MIN	MAX	

	INTOTIEO			
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.250	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.033	0.040	0.84	1.01
F	0.037	0.047	0.94	1.19
G	0.180 BSC		4.58	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
К	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29	BSC
R	0.175	0.215	4.45	5.46
S	0.020	0.050	0.51	1.27
U	0.020		0.51	
V	0.030	0.050	0.77	1.27
Z	0.138		3.51	

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE

# **Notes**

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JAPAN: ON Semiconductor, Japan Customer Focus Center 4–32–1 Nishi–Gotanda, Shinagawa–ku, Tokyo, Japan 141–0031 Phone: 81–3–5740–2745 Email: r14525@onsemi.com

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